800

0.29

88

PG-TO247-3

٧

Ω

nC



CoolMOS[™] Power Transistor

Features

- New revolutionary high voltage technology
- Extreme dv/dt rated
- High peak current capability
- Qualified according to JEDEC¹⁾ for target applications
- Pb-free lead plating; RoHS compliant
- Ultra low gate charge
- Ultra low effective capacitances

CoolMOS[™] 800V designed for:

- Industrial application with high DC bulk voltage
- Switching Application (i.e. active clamp forward)



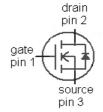


Product Summary

 $R_{DS(on)max} @ T_i = 25^{\circ}C$

 V_{DS}

 $Q_{g,typ}$



Туре	Package	Marking
SPW17N80C3	PG-TO247-3	17N80C3

Maximum ratings, at T_i =25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	ID	T _C =25 °C	17	А
		T _C =100 °C	11	
Pulsed drain current ²⁾	I _{D,pulse}	T _C =25 °C	51	
Avalanche energy, single pulse	E _{AS}	/ _D =3.4 A, V _{DD} =50 V	670	mJ
Avalanche energy, repetitive $t_{AR}^{(2),3)}$	E_{AR}	I _D =17 A, V _{DD} =50 V	0.5	
Avalanche current, repetitive $t_{AR}^{(2),3)}$	I _{AR}		17	А
MOSFET dv/dt ruggedness	dv/dt	V _{DS} =0640 V	50	V/ns
Gate source voltage	V_{GS}	static	±20	V
		AC (f>1 Hz)	±30	
Power dissipation	P_{tot}	T _C =25 °C	227	W
Operating and storage temperature	$T_{\rm j},T_{\rm stg}$		-55 150	°C
Mounting torque		M2.5 screws	50	Ncm



Maximum ratings, at T_i =25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous diode forward current	Is	. T _C =25 °C	17	А
Diode pulse current ²⁾	I _{S,pulse}	7 _C -23 C	51	
Reverse diode dv/dt ⁴⁾	dv/dt		4	V/ns

Parameter	Symbol	Conditions	Values		Unit	
			min.	typ.	max.	
Thermal characteristics						
Thermal resistance, junction - case	R_{thJC}		-	-	0.55	K/W
Thermal resistance, junction - ambient	R_{thJA}	leaded	-	-	62	
Soldering temperature, wave soldering only allowed at leads	T_{sold}	1.6 mm (0.063 in.) from case for 10s	-	-	260	°C

Electrical characteristics, at T_j =25 °C, unless otherwise specified

Static characteristics

Drain-source breakdown voltage	$V_{(BR)DSS}$	V _{GS} =0 V, I _D =250 μA	800	-	-	V
Avalanche breakdown voltage	$V_{(BR)DS}$	V _{GS} =0 V, I _D =17 A	-	870	-	
Gate threshold voltage	$V_{\rm GS(th)}$	$V_{\rm DS}=V_{\rm GS}$, $I_{\rm D}=1.0$ mA	2.1	3	3.9	
Zero gate voltage drain current	I _{DSS}	V _{DS} =800 V, V _{GS} =0 V, T _j =25 °C	1	1	25	μΑ
		V _{DS} =800 V, V _{GS} =0 V, T _j =150 °C	ı	150	1	
Gate-source leakage current	I _{GSS}	V _{GS} =20 V, V _{DS} =0 V	ı	ı	100	nA
Drain-source on-state resistance	$R_{ ext{DS(on)}}$	$V_{\rm GS}$ =10 V, $I_{\rm D}$ =11 A, $T_{\rm j}$ =25 °C	1	0.25	0.29	Ω
		V _{GS} =10 V, I _D =11 A, T _j =150 °C		0.67	-	
Gate resistance	R_{G}	f=1 MHz, open drain	-	0.85	-	Ω



Parameter	Symbol Conditions		Values			Unit
			min.	typ.	max.	
Dynamic characteristics						
Input capacitance	C _{iss}	V _{GS} =0 V, V _{DS} =100 V,	-	2300	-	pF
Output capacitance	Coss	f=1 MHz	-	94	-	
Effective output capacitance, energy related ⁵⁾	$C_{ m o(er)}$	V _{GS} =0 V, V _{DS} =0 V to 480 V	-	72	-	
Effective output capacitance, time related ⁶⁾	$C_{ m o(tr)}$		-	210	-	
Turn-on delay time	$t_{d(on)}$	V _{DD} =400 V, V _{GS} =10 V, I _D =17 A, R _G =4.7 ? ,T _j =25 °C	-	25	-	ns
Rise time	t_{r}		-	15	-	
Turn-off delay time	$t_{d(off)}$		-	72	-	
Fall time	t_{f}		-	12	-	
Gate Charge Characteristics						
Gate to source charge	Q _{gs}		-	12	-	nC
Gate to drain charge	Q_{gd}	V _{DD} =640 V, I _D =17 A,	-	45	-	
Gate charge total	Qg	V _{GS} =0 to 10 V	-	88	117	
Gate plateau voltage	V _{plateau}		-	5.5	-	V
Reverse Diode						
Diode forward voltage	V_{SD}	$V_{GS}=0 \text{ V}, I_F=I_S=17 \text{ A}, $ $T_j=25 \text{ °C}$	-	1	1.2	V
Reverse recovery time	t _{rr}	V_R =400 V, I_F = I_S =17 A, di_F / dt =100 A/ μ s	-	550	-	ns
Reverse recovery charge	Q _{rr}		-	15	-	μC
Peak reverse recovery current	/ _{rrm}		-	51	-	Α

¹⁾ J-STD20 and JESD22

²⁾ Pulse width t_p limited by $T_{j,max}$

 $^{^{3)}}$ Repetitive avalanche causes additional power losses that can be calculated as $P_{\mathrm{AV}} = E_{\mathrm{AR}} * f$.

 $^{^{4)}} I_{SD} = I_{D}, \ di/dt = 200 A/\mu s, \ V_{DClink} = 400 V, \ \ V_{peak} < V_{(BR)DSS}, \ T_j < T_{jmax}, \ identical low side and high side switch the sum of the sum of$

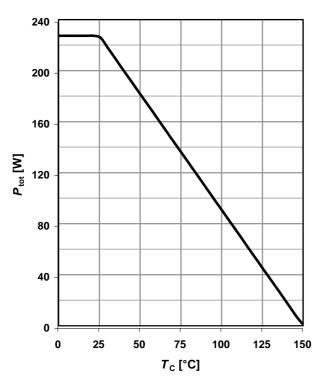
 $^{^{5)}}$ $C_{\rm o(er)}$ is a fixed capacitance that gives the same stored energy as $C_{\rm oss}$ while $V_{\rm DS}$ is rising from 0 to 80% $V_{\rm DSS}$.

 $^{^{6)}}$ $C_{\rm o(tr)}$ is a fixed capacitance that gives the same charging time as $C_{\rm oss}$ while $V_{\rm DS}$ is rising from 0 to 80% $V_{\rm DSS}$.



1 Power dissipation

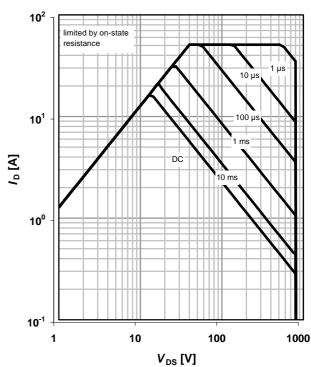
$P_{\text{tot}} = f(T_{\text{C}})$



2 Safe operating area

 $I_{D}=f(V_{DS}); T_{C}=25 \text{ °C}; D=0$

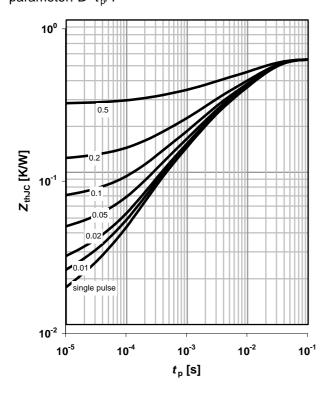
parameter: t_p



3 Max. transient thermal impedance

 $Z_{thJC}=f(t_P)$

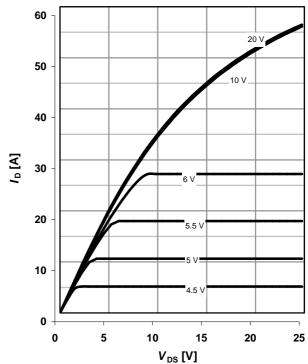
parameter: $D=t_p/T$



4 Typ. output characteristics

 I_D =f(V_{DS}); T_j =25 °C; t_p =10 μ s

parameter: V_{GS}

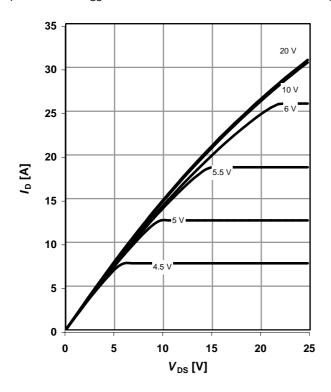




5 Typ. output characteristics

 I_{D} =f(V_{DS}); T_{j} =150 °C; t_{p} =10 μ s

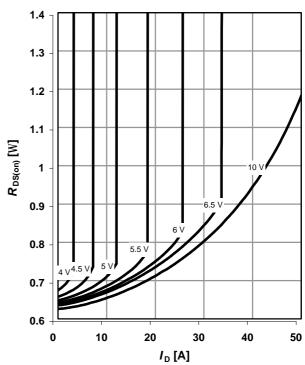
parameter: V_{GS}



6 Typ. drain-source on-state resistance

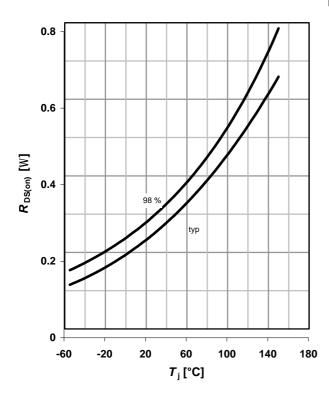
 $R_{DS(on)}=f(I_D); T_j=150 \text{ °C}$

parameter: $V_{\rm GS}$



7 Drain-source on-state resistance

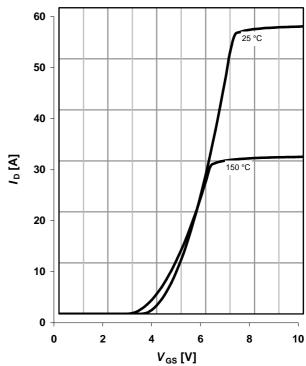
 $R_{DS(on)}=f(T_j); I_D=11 A; V_{GS}=10 V$



8 Typ. transfer characteristics

 $I_{\rm D} = f(V_{\rm GS}); |V_{\rm DS}| > 2|I_{\rm D}|R_{\rm DS(on)max}; t_{\rm p} = 10 \ \mu s$

parameter: T_i

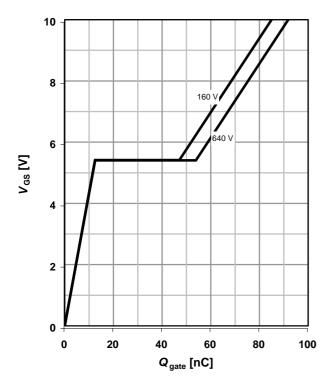




9 Typ. gate charge

 V_{GS} =f(Q_{gate}); I_D =17 A pulsed

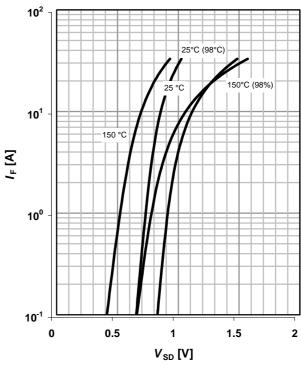
parameter: $V_{\rm DD}$



10 Forward characteristics of reverse diode

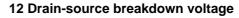
 $I_{\text{F}}=f(V_{\text{SD}}); t_{\text{p}}=10 \text{ } \mu\text{s}$

parameter: $T_{\rm j}$

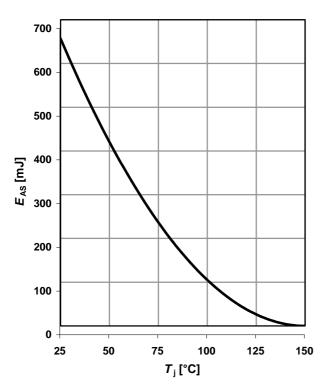


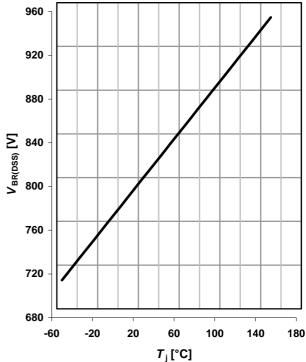
11 Avalanche energy

 $E_{AS}=f(T_i); I_D=3.4 A; V_{DD}=50 V$



 $V_{BR(DSS)}=f(T_i); I_D=0.25 \text{ mA}$





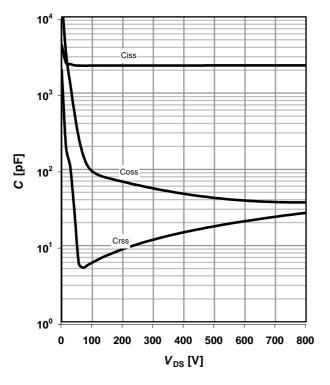


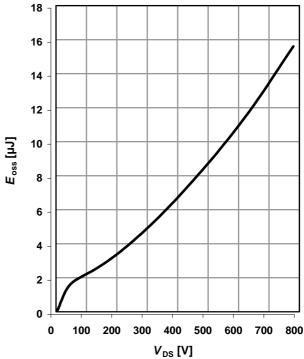
13 Typ. capacitances

 $C=f(V_{DS}); V_{GS}=0 V; f=1 MHz$

14 Typ. Coss stored energy

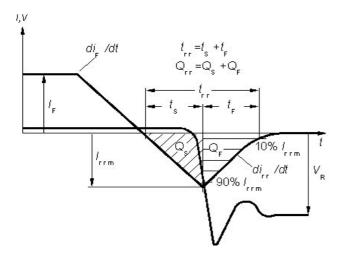
$$E_{oss} = f(V_{DS})$$





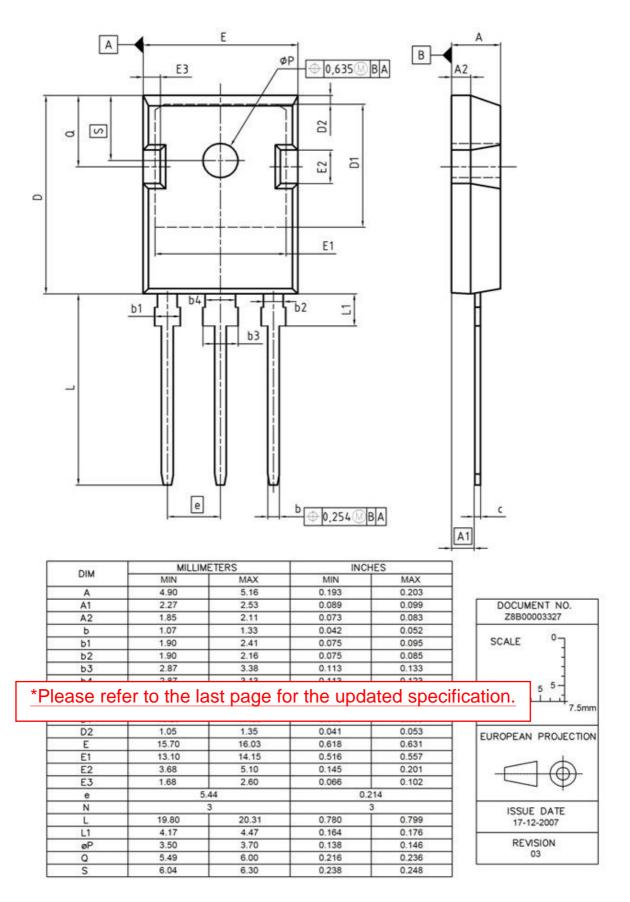


Definition of diode switching characteristics





PG-TO247-3: Outline





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New package outlines TO-247

1 New package outlines TO-247

Assembly capacity extension for CoolMOSTM technology products assembled in lead-free package PG-TO247-3 at subcontractor ASE (Weihai) Inc., China (Changes are marked in blue.)

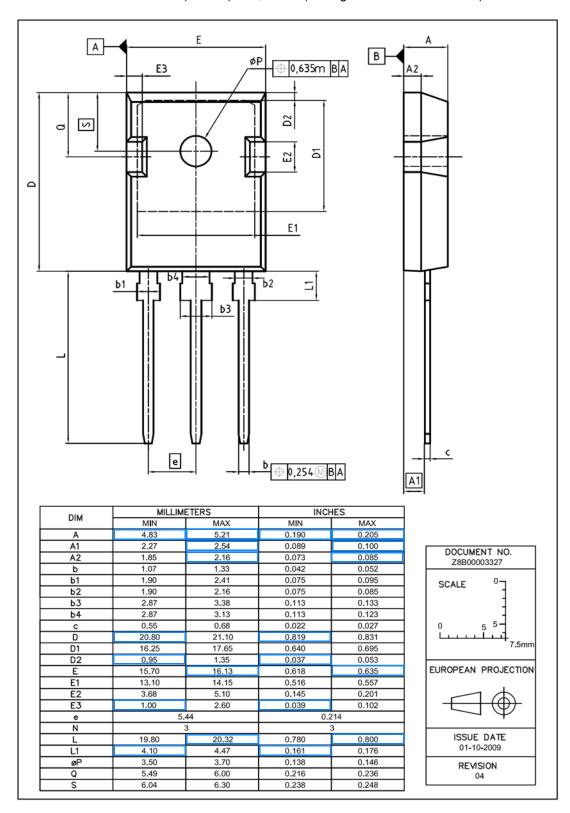


Figure 1 Outlines TO-247, dimensions in mm/inches

Final Data Sheet Erratum Rev. 2.4, 2014-04-29